

Notice of References Cited	Application/Control No. 10/533,247	Applicant(s)/Patent Under Reexamination JUNG, II-HYUNG	
	Examiner BINH K. TIEU	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0033691	02-2005	Whewell et al.	705/040
*	B	US-2004/0043754	03-2004	Whewell, Jean E.	455/408
*	C	US-5,995,822	11-1999	Smith et al.	455/406
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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